



**IEUVI Resist TWG
September 30, 2012
Brussels, Belgium**

Agenda

8:00 AM – 8:15 AM	Welcome and Introductions	<i>K. Petrillo</i>
8:15 AM – 8:35 AM	NIST Outgas Testing Update	<i>C. Tarrío</i>
8:35 AM – 8:55 AM	Contamination Evaluation Tool by an In-Situ Spectroscopic Ellipsometer With an Exposure of High Power EUV	<i>T. Watanabe</i>
8:55 AM – 9:15 AM	EIDEC Outgas Testing Update	<i>T. Takahashi</i>
9:15 AM – 9:35 AM	ROX Outgas Testing Update	<i>G. Denbeaux</i>
9:35 AM – 9:55 AM	Imec Outgas Testing Update	<i>I. Pollentier</i>
9:55 AM – 10:20 AM	Break	
10:20 AM – 10:40 AM	EUVT Outgas Testing Update	<i>R. Perera</i>
10:40 AM – 11:00 AM	Survey Results and Discussion	<i>K. Petrillo</i> <i>K.Y. Cho</i>
11:00 AM – 11:30 AM	Simulation of Stochastic Effects in EUV Resists	<i>J. Biafore</i>
11:30 AM – 11:50 AM	Resist Improvements Needed for EUVL Extension	<i>M. Neisser</i>
11:50 AM – 12:00 PM	Summary and Discussion	<i>K. Petrillo</i>

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